

Notice of References Cited	Application/Control No. 10/791,825	Applicant(s)/Patent Under Reexamination INOUE, TAKAHIRO	
	Examiner Long Nguyen	Art Unit 2816	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,756,826 B1	06-2004	Klein et al.	327/108
	B	US-6,720,819 B1	04-2004	Yamamoto, Akihisa	327/427
	C	US-6,333,665 B1	12-2001	Ichikawa, Kohsaku	327/434
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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